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1) Enter a single keyword, phrase, or Boolean expression. Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
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Example: optical <and> (fiber <or> fibre) <in> ti

3) Limit the results by selecting Search Options.
4) Click Search. See Search Examples

```
((multi*level* or (multi
<near/1> level*)) <near/1>
precedence <near/1>
pre*emption*) or mlpp or
```

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Note: This function returns plural and suffixed forms of the keyword(s).

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